

P-Channel Enhancement Mode Field Effect Transistor NDT2955

General Description

This 60 V P-Channel MOSFET is produced using **onsemi**'s high voltage Trench process. It has been optimized for power management plications.

Features

- -2.5 A, -60 V
 - $R_{DS(ON)} = 300 \text{ m}\Omega @ V_{GS} = -10 \text{ V}$
 - $R_{DS(ON)} = 500 \text{ m}\Omega @ V_{GS} = -4.5 \text{ V}$
- High Density Cell Design for Extremely Low R_{DS(ON)}.
- High Power and Current Handling Capability in a Widely Used Surface Mount Package
- This is a Pb-Free Device

Applications

- DC/DC Converter
- Power Management

ABSOLUTE MAXIMUM RATINGS (T_A = 25°C, unless otherwise noted)

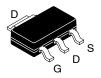
Symbol	Parameter	Value	Unit
V_{DSS}	Drain-Source Voltage	-60	V
V_{GSS}	Gate-Source Voltage	±20	V
I _D	Drain Current		Α
	Continuous (Note 1a)	-2.5	
	- Pulsed	-15	
P _D	Maximum Power Dissipation		W
	(Note 1a)	3.0	
	(Note 1b)	1.3	
	(Note 1c)	1.1	
T _J , T _{STG}	Operating and Storage Temperature Range	−55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS (T_A = 25°C, unless otherwise noted)

Symbol	Parameter	Max	Unit
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	42	°C/W
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case (Note 1)	12	°C/W

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SOT-223 CASE 318H-01

MARKING DIAGRAM



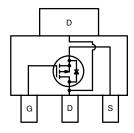
A = Assembly Location

Y = Year W = Work Week

2955 = Specific Device Code ■ Pb–Free Package

(Note: Microdot may be in either location)

PINOUT DIAGRAM



ORDERING INFORMATION

Device	Package	Shipping [†]
NDT2955	SOT-223 (Pb-Free)	4000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
VALANCHE	RATINGS					
W _{DSS}	Drain-Source Avalanche Energy	Single Pulse, $V_{DD} = 30 \text{ V}$, $I_D = 2.5 \text{ A}$	-	-	174	mJ
FF CHARA	CTERISTICS					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-60	-	_	V
ΔBV_{DSS}	Breakdown Voltage Temperature	I _D = -250 μA, Referenced to 25°C	_	-60	_	mV/°C
ΔT_{J}	Coefficient					
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -60 V, V _{GS} = 0 V	-	-	-10	μΑ
I _{GSSF}	Gate-Body Leakage, Forward	V _{GS} = -20 V, V _{DS} = 0 V	-	-	100	nA
I _{GSSR}	Gate-Body Leakage, Reverse	V _{GS} = -20 V, V _{DS} = 0 V	-	-	-100	nA
ON CHARAC	TERISTICS (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-2	-2.6	-4	V
$\Delta V_{GS(th)}$	Gate Threshold Voltage Temperature	I _D = -250 μA, Referenced to 25°C	-	5.7	_	mV/°C
ΔT_{J}	Coefficient					
	Static Drain-Source On-Resistance	$V_{GS} = -10 \text{ V}, I_D = -2.5 \text{ A}$	_	95	300	mΩ
		$V_{GS} = -4.5 \text{ V}, I_D = -2 \text{ A}$	-	163	500	1
		$V_{GS} = -10 \text{ V}, I_D = -2.5 \text{ A}, T_J = 125^{\circ}\text{C}$	_	153	513	1
I _{D(ON)}	On-State Drain Current	V _{GS} = -10 V, V _{DS} = -5 V	-12	-	_	Α
9FS	Forward Transconductance	$V_{DS} = -10 \text{ V}, I_D = -2.5 \text{ A}$	_	5.5	-	S
YNAMIC CH	IARACTERISTICS					
C _{iss}	Input Capacitance	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	_	601	_	pF
C _{oss}	Output Capacitance	7	_	85	_	pF
C _{rss}	Reverse Transfer Capacitance	7	_	35	_	pF
WITCHING	CHARACTERISTICS (Note 2)				•	
t _{d(on)}	Turn – On Delay Time	$V_{DD} = -30 \text{ V}, I_D = -1 \text{ A},$	-	12	21	ns
t _r	Turn – On Rise Time	$V_{GS} = -10 \text{ V}, R_{GEN} = 6 \Omega$	-	10	20	ns
t _{d(off)}	Turn – Off Delay Time	7	-	19	34	ns
t _f	Turn – Off Fall Time	7	-	6	12	ns
Qg	Total Gate Charge	$V_{DS} = -30 \text{ V}, I_D = -2.5 \text{ A}, V_{GS} = -10 \text{ V}$	-	11	15	nC
Q _{gs}	Gate-Source Charge]	-	2.4	_	nC
Q _{gd}	Gate-Drain Charge	7	_	2.7	-	nC
	RCE DIODE CHARACTERISTICS AND MA	XIMUM RATINGS				
Is	Maximum Continuous Drain-Source Diod	e Forward Current	-	-	-2.5	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = -2.5 A (Note 2)	-	-0.8	-1.2	V
t _{rr}	Diode Reverse Recovery Time	I _F = -2.5 A,	-	25	_	ns
Q _{rr}	Diode Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$	_	40	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

^{1.} $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 42°C/W when mounted on a 1 in² pad of 2 oz copper.



b. 95°C/W when mounted on a 0.066 in² pad of 2 oz copper.

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c. 110°C/W when mounted on a minimum pad.

2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%.

NDT2955

TYPICAL CHARACTERISTICS

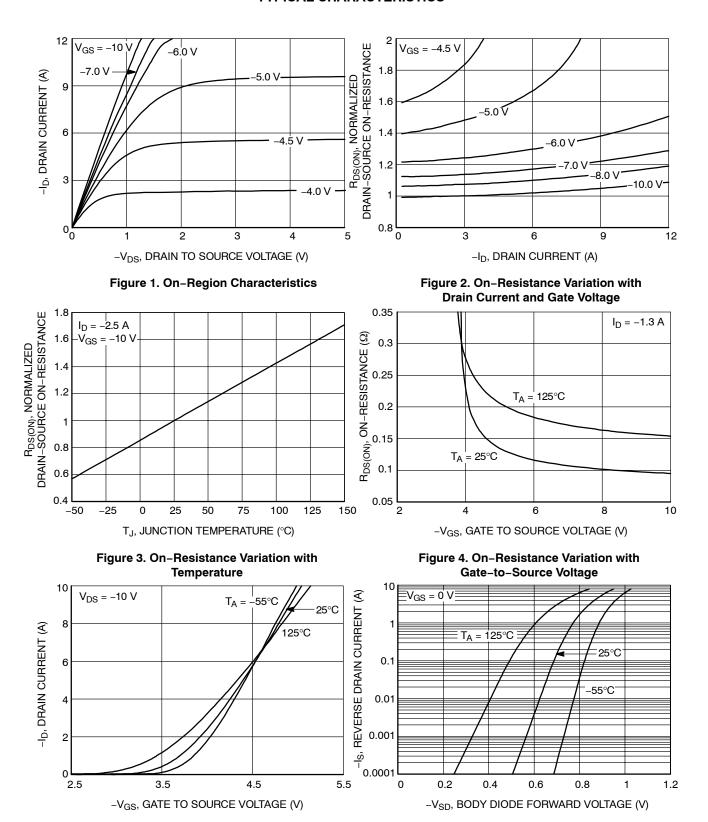
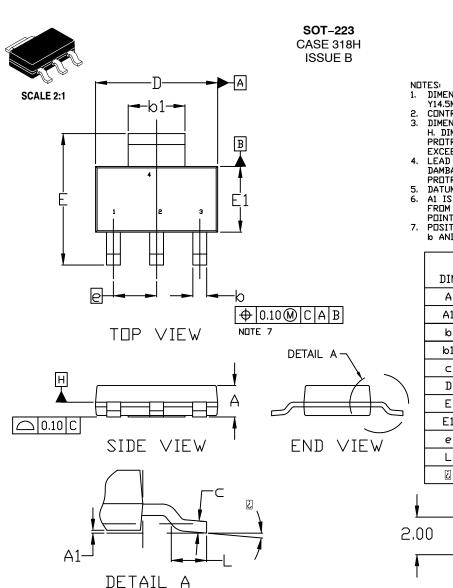


Figure 5. Transfer Characteristics

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature



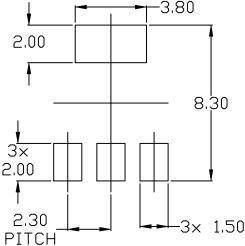


DATE 13 MAY 2020

- DIMENSIONING AND TOLERANCING PER ASME
- DIMENSIDNING AND TOLERANCING PER ASME Y14.5M, 2009.
 CONTROLLING DIMENSION: MILLIMETERS DIMENSIONS D & E1 ARE DETERMINED AT DATUM H. DIMENSIONS DO NOT INCLUDE MOLD FLASH, PROTRUSIONS DR GATE BURRS. SHALL NOT EXCEED 0.23mm PER SIDE.
 LEAD DIMENSIONS & AND &1 DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBBAR PROTRUSION. ALLOWABLE DAMBBAR PROTRUSION IS 0.08mm PER SIDE.
 DATUMS A AND B ARE DETERMINED AT DATUM H. A1 IS DEFINED AS THE VERTICAL DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT OF THE PACKAGE BODY.
 POSITIONAL TOLERANCE APPLIES TO DIMENSIONS & AND &1.

- b AND b1.

	MILLIMETERS			
DIM	MIN.	N□M.	MAX.	
Α			1.80	
A1	0.02	0.06	0.11	
b	0.60	0.74	0.88	
b1	2.90	3.00	3.10	
С	0.24		0.35	
D	6.30	6.50	6.70	
E	6.70	7.00	7.30	
E1	3,30	3.50	3.70	
е	2.30 BSC			
L	0.25			
į.	0°		10°	



GENERIC MARKING DIAGRAM*



= Assembly Location Υ

= Year

W = Work Week

XXXXX = Specific Device Code

= Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the IIN Semiconductor Soldering and Mounting Techniques Reference Manual, SILDERRM/D.

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